

K4043LS-VB Datasheet

N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, e}	Q _g (Typ)	
30	0.010 at V _{GS} = 10 V	68	82 nC	
	0.012 at V_{GS} = 4.5 V	62	02 110	



FEATURES

- Trench Power MOSFET
- 100 % R_g and UIS Tested •
- Compliant to RoHS Directive 2011/65/EU

APPLICATIONS

- OR-ing
- Server
- DC/DC

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30		
Gate-Source Voltage		V _{GS}	± 20	V
	T _C = 25 °C		68 ^{a, e}	A
Continuous Drain Current (T _J = 175 °C)	T _C = 70 °C		62 ^e	
	T _A = 25 °C	I _D	68.8 ^{b, c}	
	T _A = 70 °C		57 ^{b, c}	A
Pulsed Drain Current		I _{DM}	90	
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	36	
Single Pulse Avalanche Energy	L = 0.1 IIIH	E _{AS}	64.8	V
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	90 ^{a, e}	^
	T _A = 25 °C	IS	3.13 ^{b, c}	— A
Maximum Power Dissipation	T _C = 25 °C		250 ^a	
	T _C = 70 °C	P _D	175	۱۸/
	T _A = 25 °C	۲D	3.75 ^{b, c}	W
	T _A = 70 °C		2.63 ^{b, c}	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Тур.	Max.	Unit
Maximum Junction-to-Ambient ^{b, d}	$t \le 10 \text{ sec}$	R _{thJA}	32	40	°C/W
Maximum Junction-to-Case	Steady State	R _{thJC}	0.5	0.6	0,00

Notes:

a. Based on $T_C = 25 \text{ °C}$. b. Surface mounted on 1" x 1" FR4 board.

d. Maximum under steady state conditions is 90 °C/W.

e. Calculated based on maximum junction temperature. Package limitation current is 90 A.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static			•	*		•
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		35		m)//8C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 7.5		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1.5		2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zana Osta Maltana Dasia Osmaal		$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	90			Α
		V _{GS} = 10 V, I _D = 28.8 A		0.010		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 27 A		0.012		Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 28.8 A		160		S
Dynamic ^b			1			I
Input Capacitance	C _{iss}			1400		
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		1200		pF
Reverse Transfer Capacitance	C _{rss}			970		1
	Qg	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 28.8 A	1	171	257	
Total Gate Charge				81.5	123	
Gate-Source Charge	Q _{gs}	V_{DS} = 15 V, V_{GS} = 4.5 V, I_{D} = 28.8 A		34		nC
Gate-Drain Charge	Q _{gd}			29		
Gate Resistance	R _g	f = 1 MHz		1.4	2.1	Ω
Turn-On Delay Time	t _{d(on)}			18	27	
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.625 Ω		11	17	1
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ 24 A, V_{GEN} = 10 V, R_g = 1 Ω		70	105	1
Fall Time	t _f			10	15	
Turn-On Delay Time	t _{d(on)}			55	83	ns
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.67 Ω		180	270	1
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 22.5 A, V_GEN = 4.5 V, R_g = 1 Ω		55	83	1
Fall Time	t _f			12	18	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			90	•
Pulse Diode Forward Current ^a	I _{SM}			1	90	A
Body Diode Voltage	V _{SD}	I _S = 22 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			52	78	ns
Body Diode Reverse Recovery Charge	Q _{rr}			70.2	105	nC
Reverse Recovery Fall Time	t _a	$I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		27		
Reverse Recovery Rise Time	t _b			25		ns

Notes:

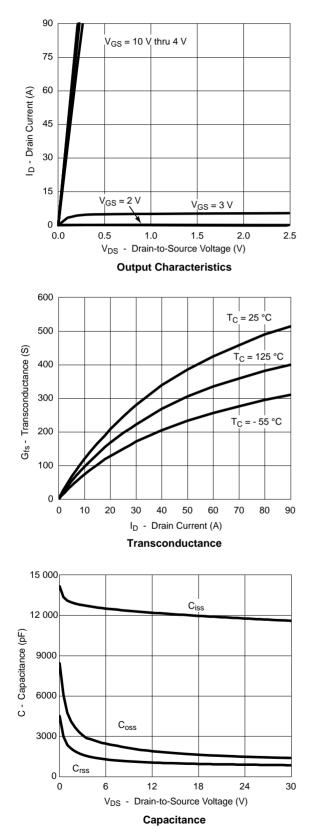
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

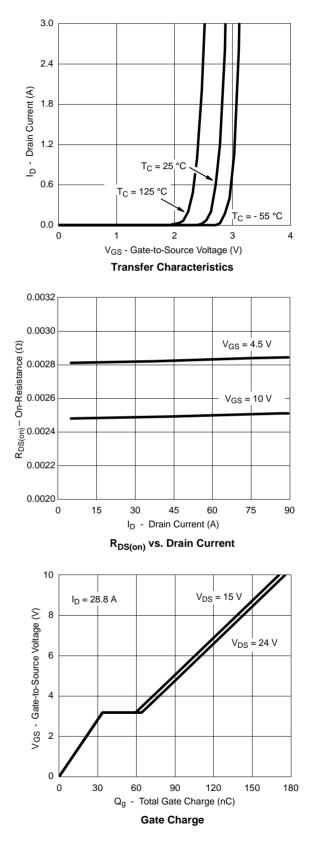
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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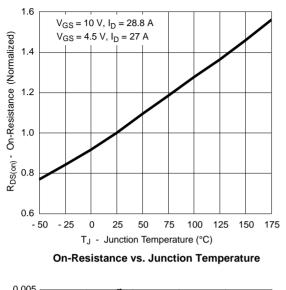




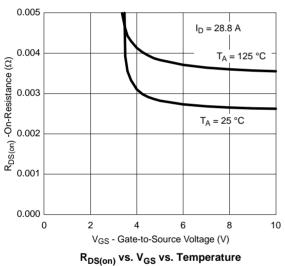
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

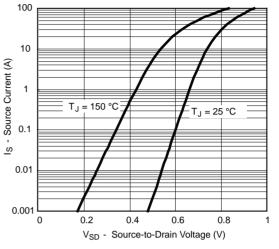




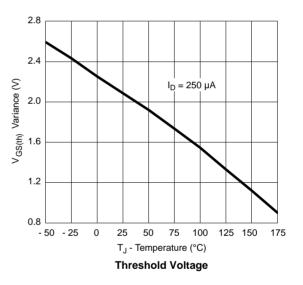


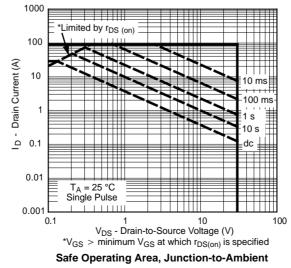
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



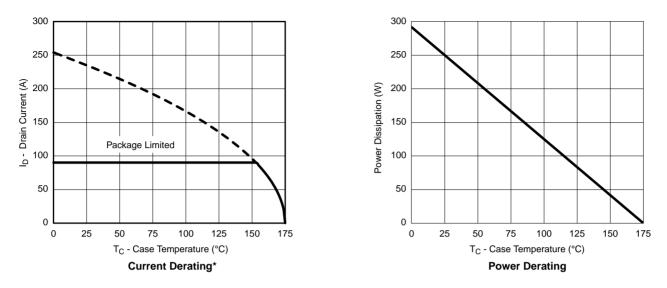


Forward Diode Voltage vs. Temperature



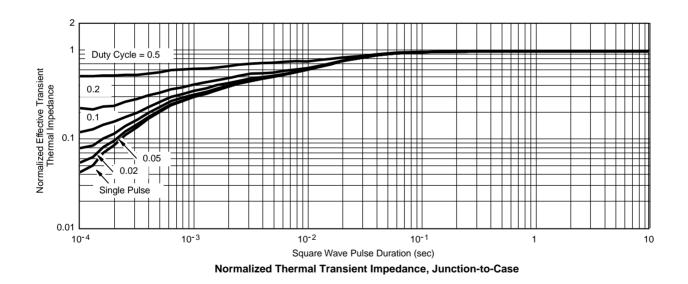






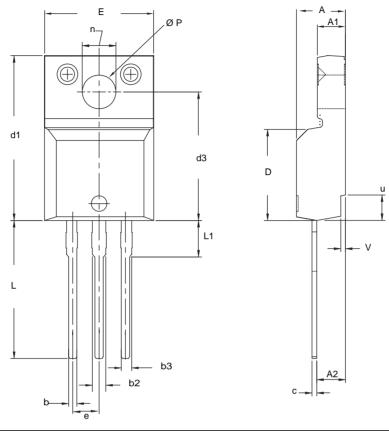
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

*The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





TO-220 FULLPAK (HIGH VOLTAGE)



MIN. 4.570 2.570 2.510 0.622 1.229 0.440 8.650	MAX. 4.830 2.830 2.850 0.890 1.400 1.400 0.629	MIN. 0.180 0.101 0.099 0.024 0.048 0.048 0.048	MAX. 0.190 0.111 0.112 0.035 0.055 0.055
2.570 2.510 0.622 1.229 1.229 0.440	2.830 2.850 0.890 1.400 1.400	0.101 0.099 0.024 0.048 0.048	0.111 0.112 0.035 0.055 0.055
2.510 0.622 1.229 1.229 0.440	2.850 0.890 1.400 1.400	0.099 0.024 0.048 0.048	0.112 0.035 0.055 0.055
0.622 1.229 1.229 0.440	0.890 1.400 1.400	0.024 0.048 0.048	0.035 0.055 0.055
1.229 1.229 0.440	1.400 1.400	0.048 0.048	0.055 0.055
1.229 0.440	1.400	0.048	0.055
0.440			
	0.629	0.017	
8.650	4	0.017	0.025
	9.800	0.341	0.386
15.88	16.120	0.622	0.635
12.300	12.920	0.484	0.509
10.360	10.630	0.408	0.419
2.54 BSC		0.100 BSC	
13.200	13.730	0.520	0.541
3.100	3.500	0.122	0.138
6.050	6.150	0.238	0.242
3.050	3.450	0.120	0.136
2.400	2.500	0.094	0.098
0.400	0.500	0.016	0.020
	12.300 10.360 2.54 13.200 3.100 6.050 3.050 2.400	12.300 12.920 10.360 10.630 2.54 BSC 13.200 13.730 3.100 3.500 6.050 6.150 3.050 3.450 2.400 2.500	12.300 12.920 0.484 10.360 10.630 0.408 2.54 BSC 0.100 13.200 13.730 0.520 3.100 3.500 0.122 6.050 6.150 0.238 3.050 3.450 0.120 2.400 2.500 0.094

Notes

1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet $C_{pk} > 1.33$. 4. All dimensions include burrs and plating thickness. 5. No chipping or package damage.



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